Evaluation of Laminates in Pb-free HASL Process and Pb-free Assembly Environment

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Abstract

An evaluation of four FR4 laminates in commonly used stack-ups was done to determine their survivability for the Pb-free HASL process followed by a worst case Pb-free manufacturing environment of 6 X reflow @ 260°C and 1 X wave @ 270°C. The work also includes a laminate compatibility study in a Pb-free hot air solder leveling (HASL) profile.

Introduction

This project evaluated four different FR4 low cost laminates that were recommended by various PCB suppliers or are in niche uses. Pb-free HASL process was added to give an additional environmental stress and further evaluation of vertical and horizontal Pb-free HASL processes. The test vehicles consist of 4 different materials, 2 different layer counts each, 4 different surface finishes and 2 different resin contents. Results include visual inspection of the materials after 1X vertical Pb-free HASL, 6X Pb-free reflow and 1X Pb-free wave, connectivity testing after each thermal cycle and scanning acoustic microscopy (SAM) scans. Cross-section work is still to be performed on selected locations where voids or delamination were detected on the board during SAM.

This paper focuses on 2 main evaluations. DOE1 studies the vertical Pb-free HASL thermal profiling in comparison to the tin lead HASL profiles at the PCB fabricators. DOE2 focuses on the survivability of the test vehicles through the Pb-free HASL plating process and a worst case Pb-free manufacturing environment.

DOE1 Vertical Pb-free HASL Thermal Profile

The objective of this design of experiments is to compare internal and surface temperatures of 2 PCB materials during the HASL dipping process in tin lead and Pb-free nickel-doped tin-copper (SnCuNi) solder alloy. The board features are as detailed below.

Test vehicle size: 11" x 11"

Layer count: 10

Overall board thickness: 1.9mm

Board material (A1, A2, B): High T_g laminate

Table 1: DOE1 Test Condition

	Laminate A1 in SnPb	Laminate A2 in SnCuNi	Laminate B in SnCuNi
Solder Temperature, °C	260	265	265
Dipping Time, sec	7	7	5

Note: No Air Knife was used during the evaluation.

Thermocouples 1, 3 and 5 (blue squares) were secured on the PCB surface, whereas thermocouples 2, 4 and 6 (red circles) were embedded into the center of the internal PCB stack-up, all with high temperature wires and epoxy.

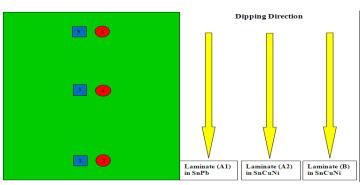


Figure 1: Thermocouple Locations

Fig. 2: Thermocouples mounted on the profile board

DOE2: Extreme Pb-free Assembly Process Survivability

This DOE evaluates the survivability of various combinations of surface finishes with 4 different types of laminates through the Pb-free HASL process (for HASL plated board) followed by 7 thermal cycles of Pb-free soldering. The test boards were then sent for SAM to check for inner layer defects.

Design of Experiment

The test boards were designed with a daisy chain and fabricated using 2 different stack-ups, 10 and 18 layer constructions respectively, and no plane layers. PCB materials A and B are non-filled and filled versions of a phenolic FR4 which were chosen as the baseline materials for comparison. Materials A and B are high- T_g whereas C and D are mid- T_g materials. The overall design of experiment 2 is shown in Table 2 below.

PCB Material	Resin type	Layer Count	ImmAg	SnPb HASL	Vertical SnCuNi HASL	Horizontal SnCuNi HASL	Extreme Pb-free Process	SAM	Cross- section
	Unfilled	10L	40	12	12	12	76	26	13
\mathbf{A}	Phenolic	18L	12	8	8	8	36	24	12
	Filled	10L	40	12	12	12	76	26	13
В	Phenolic	18L	12	8	8	8	36	10	5
	Filled	10L	8	4	12	8	32	14	7
C	Phenolic	18L	8	4	12	8	32	20	10
	Unfilled	10L	8	0	12	12	32	12	6
D	Dicy	18L	8	0	12	12	32	16	8

Table 2: DOE2 Test Conditions

All test boards with various combinations of laminate and surface finishes were pre-conditioned through a worst case scenario of Pb-free assembly environment, comprising 6 reflow cycles @260°C peak for 10 seconds and 1 cycle through wave @270°C peak for 7 seconds. The test boards were not baked prior to reflow. They were taken out of the packaging material and used as received. Prior to the start of each pre-conditioning run, the reflow and wave profiles were verified to validate that nothing changed between when the profiles were generated and when the actual board pre-conditioning run took place. During the actual runs, the boards were introduced into the oven with a minimum board spacing of at least 2 zones. This ensured there were no thermal interactions between boards. Furthermore, each board was allowed to cool to room temperature (approximately 20 minutes) before being reflowed again, to ensure that each board experienced the same thermal excursion during each thermal cycle. Open/short measurements were taken before and after every thermal cycle to detect any onset of electrical failures.

A total of 148 boards were selected for SAM (Scanning Acoustic Microscopy) to detect any delamination or voids or cracks in the board internal layers. THRU-Scan is the imaging mode that was chosen for this experiment where the ultrasound that propagates through the entire thickness of the board is captured. This mode of operation provides an overall shadow graphic view of the board. Since the ultrasound will not pass through any air space (delamination, crack or void) the blockage of signal is observed as dark areas in its resulting image.

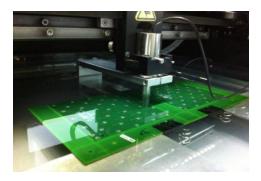


Figure3: Thru-scan in operation

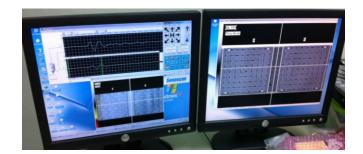


Figure4: Thru-scan imaging

Experiment Results

DOE1: Vertical Pb-free HASL Thermal Profile

Based on the data compilation in table 3 below, the following results were observed. Due to the nature of the vertical HASL process, the leading edge of the board to first dive into the solder pot is also the trailing edge to last resurface from the pot, hence the First-In-Last-Out (FILO) and Last-In-First-Out (LIFO) sequence.

Laminate type Laminate A1 Laminate A2 Laminate B T-5 T-2 T-2 T-6 **Overall Profile** Solder alloy **SnPb** SnCuNi SnCuNi T_o, °C 175 DSC 175 DSC 180 DSC 260 265 265 Solder Pot Temp, °C Dipping Time, sec 7 7 5 Surface T1 (FILO) 226 227 227 **Peak** 180 223 **T3** 211 Temp. °C T5 (LIFO) 188 172 217 Internal 188 193 T2 (FILO) 202 **Peak T4** 172 169 179 Temp, °C 169 172 T6 (LIFO) 128

Table 3: Thermo Profile and Data Compilation

- 1. Comparing the same laminate type, A1 and A2 were dipped into SnPb and SnCuNi respectively for the same dipping time.
 - The surface temperatures peaked at 226°C for SnPb and 227°C for SnCuNi.
 - The internal peak temperatures are 188°C for SnPb and 202°C for SnCuNi.

Referring to the properties of SnCuNi, this alloy has a lower spread factor, longer wettability and higher surface tension, plus a higher pot temperature is used. In this study where the same dipping time is used, the SnCuNi is hotter than the SnPb for the FILO board and lower for the LIFO.

- 2. Comparing different laminates A2 and B, dipped into SnCuNi for 7 and 5 sec respectively.
 - For both A2 and B, board surface peaked at 227°C, although there was more uniformity of temperature along the panel length for B.
 - For internal, A2 peaked at 202°C, B peaked at 193°C, with B again having less variation in temperature between FILO and LIFO boards.
 - B, a filled laminate, had temperatures that were more uniform along the panel length, implying faster heat absorption.
- 3. Comparing different laminates A1 and B, dipped into SnPb and SnCuNi for 7 and 5 sec respectively with 5°C difference in solder pot temperature.
 - A1 board surface in SnPb peaked at 226°C, B in SnCuNi peaked at 227°C.
 - For internal, A1 in SnPb peaked at 188°C, B in SnCuNi peaked at 193°C.

^{*} Control board under known conditions

^{**}Typical SnPb HASL solder pot peak temp. (°C); dipping time (s): 240-270; 1-4 sec

^{***}Typical Pb-Free HASL solder pot peak temp. (°C); dipping time (s): 260-275; 1-5 sec

B temperatures were higher in a hotter solder pot, although at a shorter dip time.

DOE2: Extreme Pb-free Assembly Process Survivability

This DOE evaluated the survivability of various combinations of surface finishes with 4 different types of laminates through the Pb-free HASL process (for those with HASL coating) followed by 7 thermal cycles of Pb-free soldering. The test boards were evaluated with SAM scans to check for inner layer defects. The results of the scans are shown in table 4 below.

Table 4: Extreme Pb-free Process Conditioning and SAM Scan Results by Reject Rate

Laminate	Table 4: Extreme Po-free Process Conditioning and SAM Scan Results by Reject Rate							
SnPb HASL 10L 12 12 6 6 0% 17% 12 12 12 6 17% 17% 12 12 12 6 17% 13% 14 15 15 15 16 16 16 16 16	Laminate	Finish	Layer	Visual	Continuity Test	# of Scanned brds	Scanned Reject Rate (%)	
Vert. Pb-free HASL 10L 12 12 6 33% ImmAg	-	ImmAg	10L	36	33	8	38%	
Vert. Pb-free HASL 12 12 6 33%		SnPb HASL		12	12	6	0%	
ImmAg		Vert. Pb-free HASL		12	12	6	17%	
ImmAg SaPb HASL 18L 18L 8	A	Horiz. Pb-free HASL		12	12	6	33%	
Vert. Pb-free HASL 18L 8 8 8 6 67%	1.	ImmAg		12	12	6	33%	
Note		SnPb HASL	101	8	8	6	0%	
ImmAg SnPb HASL 10L 12 12 12 6 0% 0% 12 12 12 6 0% 0% 12 12 12 6 0% 0% 12 12 12 6 0% 0% 12 12 12 12 13 10 10 10 10 10 10 10		Vert. Pb-free HASL	18L	8	8	6	67%	
SnPb HASL Vert. Pb-free HASL 10L 12 12 12 6 0%		Horiz. Pb-free HASL		8	8	6	0%	
Vert. Pb-free HASL 10L 12 12 6 0%		ImmAg		36	34		25%	
Horiz, Pb-free HASL 12 12 6 0%		SnPb HASL	4.07	12	12	6	0%	
TimmAg		Vert. Pb-free HASL	10L	12	12	6	0%	
ImmAg	R	Horiz. Pb-free HASL		12	12	6	0%	
Vert. Pb-free HASL 18L 8	ь	ImmAg		12	11	4	100%	
Horiz. Pb-free HASL 8 8 2 100%		SnPb HASL	18L				0%	
ImmAg SnPb HASL 10L 12 12 6 33%		Vert. Pb-free HASL		8	8	2	100%	
SnPb HASL Vert. Pb-free HASL Vert. Pb-free HASL Vert. Pb-free HASL SnPb HASL Vert. Pb-free HASL Vert		Horiz. Pb-free HASL		8	8	2	100%	
Vert. Pb-free HASL 10L 12 12 6 33% Horiz. Pb-free HASL 8 8 2 100% ImmAg 8 8 4 50% SnPb HASL 18L 4 4 4 0% Vert. Pb-free HASL 18L 12 12 6 33% ImmAg 8 8 4 75% Vert. Pb-free HASL 10L 12 12 4 0% ImmAg 10L 12 12 4 50% ImmAg 8 8 6 33% Vert. Pb-free HASL 18L 11 12 6 33%		ImmAg		8	8	4	50%	
Vert. Pb-free HASL 12 12 6 33%		SnPb HASL	4.07	4	4	2	0%	
C ImmAg SnPb HASL 18L 18L 4 4 4 4 0%		Vert. Pb-free HASL	10L	12	12	6	33%	
SnPb HASL 18L 18L 12 12 6 33%	C	Horiz. Pb-free HASL		8	8	2	100%	
Vert. Pb-free HASL 18L 12 12 6 33% Horiz. Pb-free HASL 8 8 6 33% ImmAg 8 8 4 75% Vert. Pb-free HASL 10L 12 12 4 0% Horiz. Pb-free HASL 12 12 4 50% ImmAg 8 8 6 33% Vert. Pb-free HASL 18L 11 12 6 33% Vert. Pb-free HASL 18L 18L	C	ImmAg		8	8	4	50%	
Vert. Pb-free HASL		SnPb HASL	101	4	4	4	0%	
ImmAg Vert. Pb-free HASL 10L 12 12 4 0%		Vert. Pb-free HASL	18L	12	12	6	33%	
Vert. Pb-free HASL 10L 12 12 4 0% Horiz. Pb-free HASL 12 12 4 50% ImmAg 8 8 6 33% Vert. Pb-free HASL 18L 11 12 6 33%		Horiz. Pb-free HASL		8	8	6	33%	
D Horiz. Pb-free HASL 12 12 4 50% ImmAg 8 8 6 33% Vert. Pb-free HASL 18L 11 12 6 33%		ImmAg		8	8	4	75%	
ImmAg 8 8 6 33% Vert. Pb-free HASL 18L 11 12 6 33%		Vert. Pb-free HASL	10L	12	12	4	0%	
ImmAg 8 8 6 33% Vert. Pb-free HASL 18L 11 12 6 33%	D	Horiz. Pb-free HASL		12	12	4	50%	
	_ D	ImmAg		8	8	6	33%	
Horiz, Pb-free HASL 9 12 4 25%		Vert. Pb-free HASL	18L	11	12	6	33%	
		Horiz. Pb-free HASL		9	12	4	25%	
Total 343 338 148	Total			343	338	148		

^{*}ImmAg and SnPb HASL are control board finishes

^{**} Laminate A and B are high-Tg laminates, C and D are mid-Tg laminates



Table 5: Extreme Pb-free Process Conditioning and SAM Scan Results by Failure Symptom

Table 5: Extreme Pb-free Process Conditioning and SAM Scan Results by Failure Symptom							
Laminate	Finish	Layer	Extreme Pb-Free process conditioning	SAM			
	ImmAg	10L	Missing pads after wave soldering	Small voids			
	SnPb HASL			OK			
	Vert. Pb-free HASL	IUL		Small voids			
${f A}$	Horiz. Pb-free HASL			Small voids			
A	ImmAg			Small voids			
	SnPb HASL	18L		OK			
	Vert. Pb-free HASL	loL		Small voids			
	Horiz. Pb-free HASL			OK			
	ImmAg		Missing pads after wave soldering	Small voids			
	SnPb HASL	10L		OK			
	Vert. Pb-free HASL	IUL		OK			
В	Horiz. Pb-free HASL			OK			
ъ	ImmAg		Missing pads after wave soldering	Small voids			
	SnPb HASL	18L		OK			
	Vert. Pb-free HASL	10L		Small voids			
	Horiz. Pb-free HASL			Small voids			
	ImmAg			Small voids			
	SnPb HASL	10L		OK			
	Vert. Pb-free HASL			Small voids			
C	Horiz. Pb-free HASL			Small voids			
C	ImmAg			Small voids			
	SnPb HASL	18L		OK			
	Vert. Pb-free HASL			Small voids			
	Horiz. Pb-free HASL			Small voids			
	ImmAg			Small voids			
	Vert. Pb-free HASL	10L		OK			
D	Horiz. Pb-free HASL			Small voids			
	ImmAg			Small voids			
	Vert. Pb-free HASL	18L	Board warp	Small voids			
	Horiz. Pb-free HASL		Board warp	Delam			

^{*}ImmAg and SnPb HASL are control board finishes

***'A' TVs were built by supplier X, ImmAg by X, vert. SnPb & Pb-free HASL by Y and horiz. Pb-free HASL by Z

****'B' TVs were built by supplier X, ImmAg by X, vert. SnPb & Pb-free HASL by Y and horiz. Pb-free HASL by Z

*****'C' TVs were built by supplier W, ImmAg & vert. Pb-free HASL by W, SnPB HASL by Y and horiz. Pb-free HASL by Z

*****'D TVs were built by supplier V, ImmAg, vert. & horiz. Pb-free HASL by V



Laminate/Layer/ **Surface Finish Photos** Zoom-in photos Laminate A (10 layers) **Immersion Silver** Laminate A (10 layers) **Horizontal Pb-free** HASL Laminate A (18 lavers) **Vertical Pb-free HASL** Laminate C (18 layers) **Immersion Silver Laminate D** (18 layers) **Horizontal Pb-free** HASL

Table 6: Samples photos of voids/delamination:

Discussion of Results

- 1. All control boards with SnPb HASL had no voiding. The immersion silver boards, which had 1 fewer thermal cycle than any of the HASL boards, showed voiding. We do not understand this since logically the immersion silver should have had less voiding than even SnPb HASL. It seems unlikely that random variation in the base material would have produced this result, but no plausible explanation is known for the difference when writing this paper.
- 2. The immersion silver boards showed the same level of voiding as Pb-free HASL. This shows that the Pb-free HASL itself was not the primary factor in voiding.
- 3. Vertical and horizontal HASL did not show any difference in voiding. Thermal impact between these 2 plating processes on the boards is comparable.
- 4. Laminate D at 18L cannot survive the necessary process steps, showing delamination and warp. Board warp caused solder overflow onto the board during wave soldering. This further confirms why dicy cured materials should not be used for products which are undergoing Pb-free soldering and more so with Pb-free HASL surface finish.
- 5. Defect rate increases with higher layer count. As stack-up increases, the probability for any deficient bond between the inner layer copper oxide and the "B" stage prepreg resin could potentially increase also. This may be caused by lack of process control in any of the fabrication process, be it oxide process, control of heat-up rate during lamination, prepreg with lower surface resin or control of etch back process.
- 6. In this experiment, voids are assumed to be precursors to delamination. Boards with voids detected by SAM were sent for cross-sections. The degradation of the material is often internal and not visible to external visual inspection, necessitating SAM and cross-sections. Hence, the 99% yield for visual inspection on all boards. The 1% failure was attributed by 2 warped boards and 1 delaminated board.
- 7. Some pads on the immersion silver plated PCBs were missing after wave. The extreme soak time of 7 seconds at wave soldering reflects the worst case scenario of a Pb-free wave soldering profile. Immersion silver boards immersed in the wave solder pot for this duration had pads missing.

Conclusion

An important consideration for Pb-free materials, before any of the long-term reliability considerations are addressed, is the survivability of the laminates without degradation after the Pb-free assembly process. This survivability is further stressed if Pb-free HASL is used, which adds another thermal cycle to the board during the fabrication process. The HASL profile shows that any laminate that is currently coated with tin lead HASL should be able to withstand the Pb-free HASL processing temperatures under the same dip time conditions. The voiding of Pb-free HASL boards was the same as in the immersion silver boards after extreme assembly conditions. As a chosen Pb-free compatible material approaches the 6 reflow and 1 wave thermal cycle limit, it is evident that we are very close to discovering more potential problems, with the early onset of voids. This project concluded that material survivability performance of a Pb-free product depends on the type of material that is used and layer count of the board.

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- Schweizer for horizontal Pb-free HASL plating;
- Multek, Fastprint, Dysteg for test vehicle fabrication;
- QAV for conducting SAM Thru scans;
- Celestica JB for processing the test vehicles through the extreme Pb-free manufacturing environment;

References

- [1] "Considerations For Selecting A Printed Circuit Board Surface Finish", by R. Schueller, SMTA Int'l Proceedings, 2010.
- [2] "The hidden art of manufacturing multi-layered PCBs" by Stephen Sher, Cirtech Electronics.
- [3] "An Evaluation of Pb-free Surface Finishes' by Khaw Mei Ming, Agilent Technologies, SMTA Penang Proceedings, 2010.
- [4] "Hot air solder leveling in the Pb-free era" by Keith Sweatman, Nihon Superior, featured in EM Asia, Sept-Oct 09.





Evaluation of Laminates in Pb-Free HASL Process and Pb-Free Assembly Environment

By Khaw Mei Ming, Andrey Lee Agilent Technologies Bayan Lepas, Malaysia





Project Overview

This paper focuses on 2 main evaluations.

- □ DOE1: Compares the vertical SnPb and Pb-free HASL thermal profile at a PCB fabricator for 2 different laminate materials.
- □ DOE2: Studies the survivability of 4 different laminates (A, B, C, D) through Pb-free HASL plating process followed by extreme Pb-free manufacturing conditions.
 - ➤ Extreme Pb-free processing conditions: 2x reflow @260° C peak (10secs), followed by 1x wave @270° C peak (7 sec) and 4x reflow @260° C peak (10 sec).
 - ➤ Control surface finishes for comparison are SnPb HASL and immersion silver.





DOE1: Vertical Pb-Free HASL Thermal Profile

Objective

To compare 2 PCB material's internal and surface temperatures during the HASL dipping process in SnPb and SnCuNi solder alloy.

Test vehicle size: 11" x 11" Number of layer count: 10

Overall board thickness: 1.9mm

Board material (A1, A2, B): High T_a laminate

Table1: DOE1 Test Condition

	Laminate A1	Laminate A2	Laminate B
	in SnCuNi	in SnPb	in SnCuNi
Resin Type	Unfilled	Filled Phenolic	
Solder Temp., °C	265	260	265
Dipping Time, sec	7	7	5

Note: No air knife was used during the evaluation



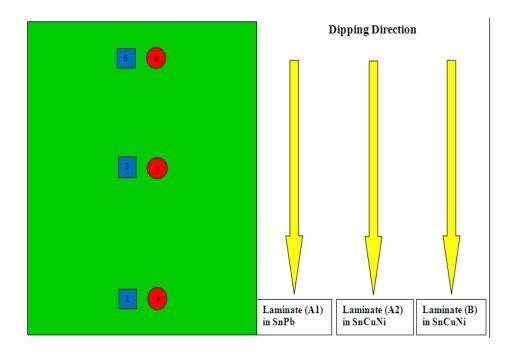


Fig.1: Thermocouple Locations



Fig.2: Thermocouples mounted on a profile board

Note

- 1. Thermocouples **1**, **3** and **5** (blue squares) were secured on the **PCB** surface using high melting point (HMP) wire and high temperature epoxy.
- 2. Thermocouples **2**, **4** and **6** (red circles) were embedded into the center of the internal PCB stack-up and secured using high temperature epoxy.

Table 2: Thermal Profile and Data Compilation

Lamin	ate type	Laminate A1	Laminate A2	Laminate B
Overal	l Profile	T5 T3 T1 T2 T4 T6 T6 T6 T6 T6 T6	T5 T1 T3 T4 T2 T6	T1 T3 T4 T5 T4 T6
Solde	er alloy	SnPb	SnCuNi	SnCuNi
T_{g}	,°C	175 DSC	175 DSC	180 DSC
Solder Po	t Temp, °C	260	265	265
Dipping	Time, sec	7	7	5
Surface	T1 (FILO)	226	227	227
Peak	T3	211	180	223
Temp, °C	T5 (LIFO)	188	172	217
	T2 (FILO)	188	202	193
Internal	T4	172	169	179
Peak Temp, °C	T6 (LIFO)	169	128	172

^{*} Control board under known conditions

^{**}Typical SnPb HASL solder pot peak temp.(°C)/dipping time (s): 240-270°C/1-4 sec ***Typical Pb-Free HASL solder pot peak temp.(°C)/dipping time (s): 260-275°C/1-5sec





Discussion of Results

- 1. Comparing the same type of laminate, **A1 and A2** were dipped into SnCuNi and SnPb respectively for the same dipping time.
 - The surface temperatures peaked at 226°C for SnPb and 227°C for SnCuNi.
 - The internal peak temperatures are 188°C for SnPb and 202°C for SnCuNi. Referring to the **properties of SnCuNi**, this alloy has a lower spread factor, longer wettability and higher surface tension, plus a **hotter solder pot** is used. In this study where the same length of dipping time is used, the SnCuNi is hotter than the SnPb for the FILO board, and lower for the LIFO.
- 2. Comparing different laminates **A2 and B**, dipped into SnCuNi for 7 and 5 sec respectively.
 - ■Both A2 and B board surfaces peaked at 227°C, with B having more uniform temperature along the panel length.
 - ■For internal, A2 peaked at 202°C, B peaked at 193°C with more consistent temperatures between the FILO and LIFO boards.
 - B, a filled laminate, had temperatures that were more consistent along the panel length, implying faster heat absorption.





DOE2: Pb-Free Assembly Process Survivability

This DOE evaluated the survivability of various combinations of surface finishes with 4 different types of laminates through the Pb-free HASL process (for HASL plated board) followed by 7 thermal cycles of Pb-free soldering. The test boards were evaluated with SAM scans to check for inner layer defects.

Table3: DOE2 Test Condition

PCB Material	Resin type	Layer Count	ImmAg	SnPb HASL	Vertical SnCuNi HASL	Horizontal SnCuNi HASL	Extreme Pb- Free process	SAM	Cross- section
	Unfilled	10L	40	12	12	12	76	26	13
A	Phenolic	18L	12	8	8	8	36	24	12
	Filled	10L	40	12	12	12	76	26	13
В	Phenolic	18L	12	8	8	8	36	10	5
	Filled	10L	8	4	12	8	32	14	7
C	Phenolic	18L	8	4	12	8	32	20	10
	Unfilled	10L	8	0	12	12	32	12	6
D	Dicy	18L	8	0	12	12	32	16	8





Pb-Free Process at the Contract Manufacturer (CM)

Test vehicles from PCB suppliers

Reflow 2x@260C peak, 10sec (*)

Wave 1x@270C peak, 7 sec (*)

Reflow 4x@260C peak, 10sec (*)

Thru scan SAM

(*) Open/short measurements are taken before & after every thermal cycle.

NUMBERING



Test Vehicle

Board size: 4.4" x 4.4"

Number of layers: 10 & 18

Board thickness: 0.074" & 0.087"

Via pitch: 8.8mm / 346mils Via size: 0.3mm / 11.8mils



Fig3: Sample Test Vehicle

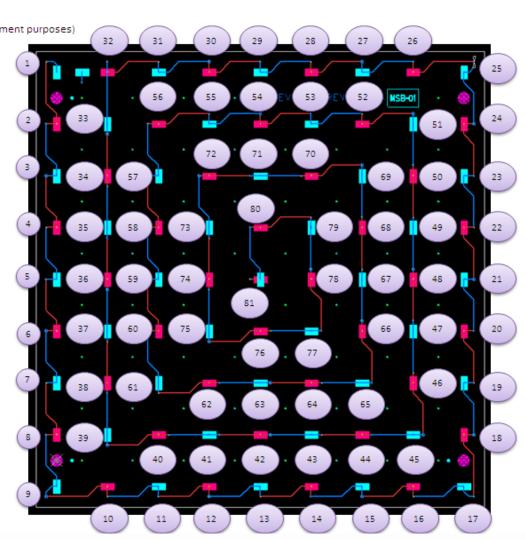


Fig4: Daisy chain links around the PCB connected through via's



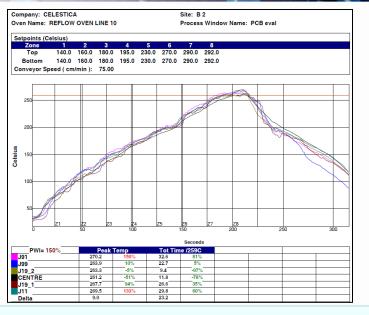


Fig5: Reflow @260C peak @ 10sec

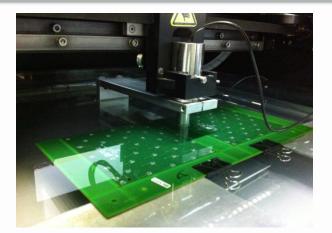


Fig7: Thru-scan in operation



Fig6: Wave @270C peak, 7sec

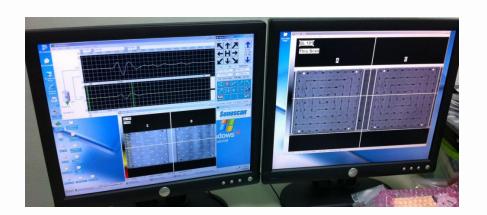


Fig8: Thru-scan imaging



Tuble 1: Extreme 1 b 11ee 11oeess conditioning to							
Laminate	Finish	Layer	Visual Insp.	Continuity Test	# of Scanned brds	Scanned Reject Rate (%)	
	ImmAg		36	33	8	38%	
	SnPb HASL		12	12	6	0%	
	Vert. Pb-Free HASL	10L	12	12	6	17%	
${f A}$	Horiz. Pb- Free HASL		12	12	6	33%	
	ImmAg		12	12	6	33%	
	SnPb HASL		8	8	6	0%	
	Vert. Pb-Free HASL	18L	8	8	6	67%	
	Horiz. Pb- Free HASL		8	8	6	0%	
	ImmAg		36	34	8	25%	
	SnPb HASL		12	12	6	0%	
	Vert. Pb-Free HASL	10L	12	12	6	0%	
В	Horiz. Pb- Free HASL		12	12	6	0%	
	ImmAg		12	11	4	100%	
	SnPb HASL		8	8	2	0%	
	Vert. Pb-Free HASL	18L	8	8	2	100%	
	Horiz. Pb- Free HASL		8	8	2	100%	

Laminate	Finish	Layer	Visual Insp.	Continuity Test	# of Scanned brds	Scanned Reject Rate (%)
	ImmAg		8	8	4	50%
	SnPb HASL		4	4	2	0%
	Vert. Pb-Free HASL	10L	12	12	6	33%
C	Horiz. Pb- Free HASL		8	8	2	100%
	ImmAg		8	8	4	50%
	SnPb HASL		4	4	4	0%
	Vert. Pb-Free HASL	18L	12	12	6	33%
	Horiz. Pb- Free HASL		8	8	6	33%
	ImmAg		8	8	4	75%
	Vert. Pb-Free HASL	10L	12	12	4	0%
D	Horiz. Pb- Free HASL		12	12	4	50%
	ImmAg		8	8	6	33%
	Vert. Pb-Free HASL	18L	11	12	6	33%
	Horiz. Pb- Free HASL		9	12	4	25%

Mid- T_g laminates

 $High-T_g\ laminates$

*ImmAg and SnPb HASL are control board finishes

10 layer boards
18 layer boards
Board warp
Missing pads

OK Small voids Delamination EXPO" 2012

Table 5: Extreme Pb-Free Process Conditioning and SAM Scan Results by Failure Symptom

Laminate	Finish	Layer	Extereme Pb-free process conditioning	SAM
	ImmAg		Missing pads after wave	Small voids
	SnPb HASL	10L		ОК
	Vert. Pb-free HASL			Small voids
A	Horiz. Pb-free HASL			Small voids
	ImmAg			Small voids
	SnPb HASL	101		OK
	Vert. LF HASL	18L		Small voids
	Horiz. LF HASL			OK
	ImmAg		Missing pads after wave	Small voids
	SnPb HASL	10L		OK
	Vert. LF HASL			OK
В	Horiz. LF HASL			OK
	ImmAg		Missing pads after wave	Small voids
	SnPb HASL	18L		ОК
	Vert Pb-free HASL			Small voids
	Horiz Pb-free HASL			Small voids

High T_a laminates

Board warp

Missing pads

Delamination

Extreme Pb-free Laminate **Finish** Layer SAM process conditioning Small voids ImmAg SnPb HASL OK 10L Vert. Pb-free HASL Small voids Small voids Horiz. Pb-free HASL \mathbf{C} immAg Small voids SnPb HASL OK IOL Vert. Pb-free HASL Small voids Horiz. Pb-free HASL Small voids ImmAg Small voids Vert. Pb-free HASL 10L OK Small voids Horiz. Pb-free HASL D Small voids ImmAg Vert. Pb-free HASL Small voids Board warp 18L Horiz. Pb-free HASL Board warp Delam 10 layer OK Mid- T_a laminates 18 layer Small voids

^{*}ImmAg and SnPb HASL are control board finishes

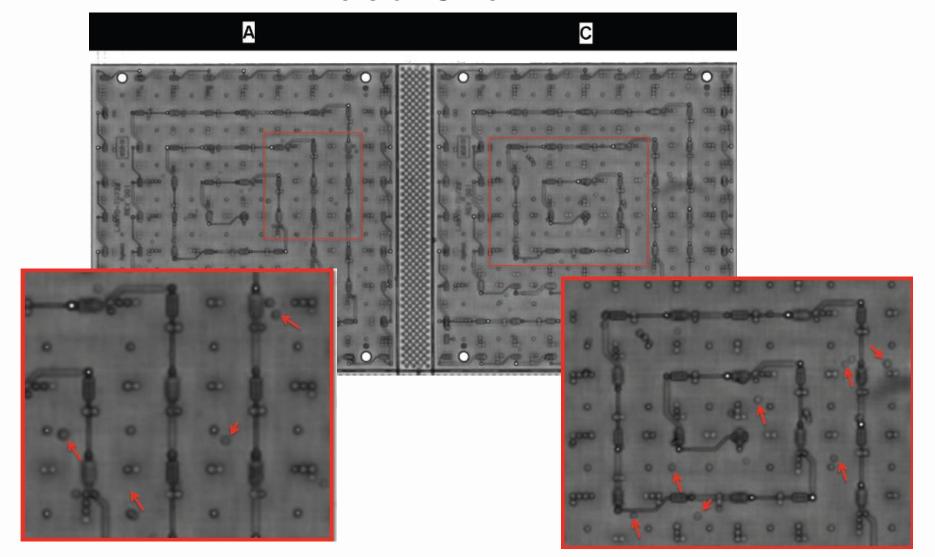
^{**&#}x27;A' TVs were built by supplier X, ImmAg by X, vert. SnPb & Pb-free HASL by Y and horiz. Pb-free HASL by Z

^{***&#}x27;B' TVs were built by supplier X, ImmAg by X, vert. SnPb & Pb-free HASL by Y and horiz. Pb-free HASL by Z

^{****&#}x27;C' TVs were built by supplier W, ImmAg & vert. Pb-free HASL by W, SnPB HASL by Y and horiz. Pb-free HASL by Z *****'D TVs were built by supplier V, ImmAg, vert.& horiz. Pb-free HASL by V

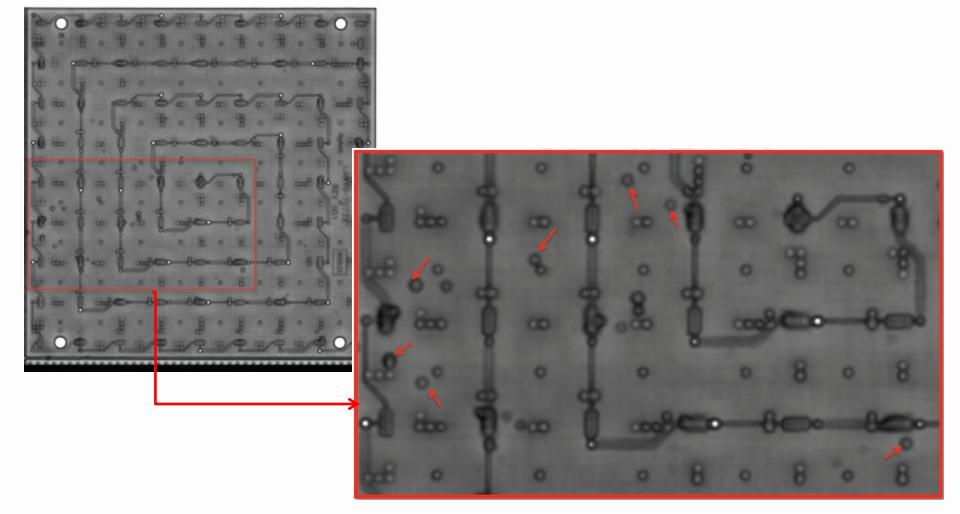


Laminate A (10 layers) Immersion Silver

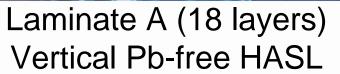




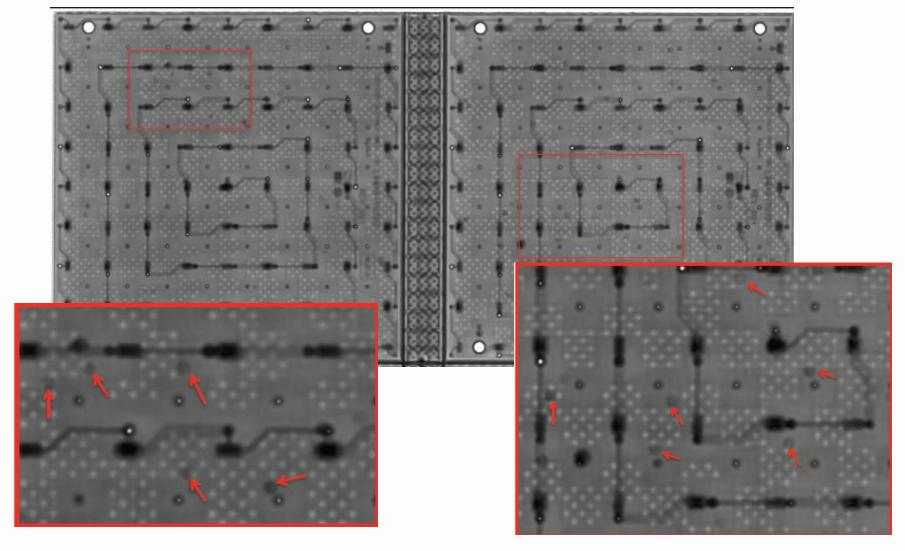
Laminate A (10 layers) Horizontal Pb-free HASL



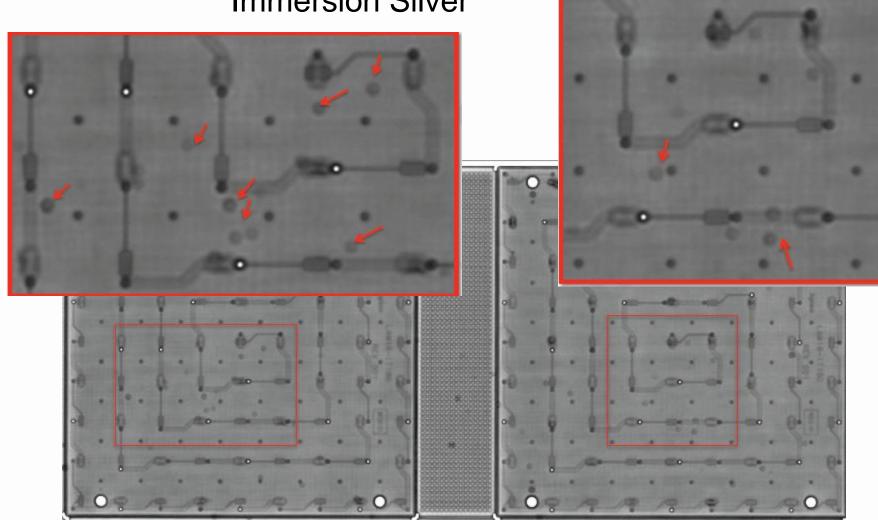




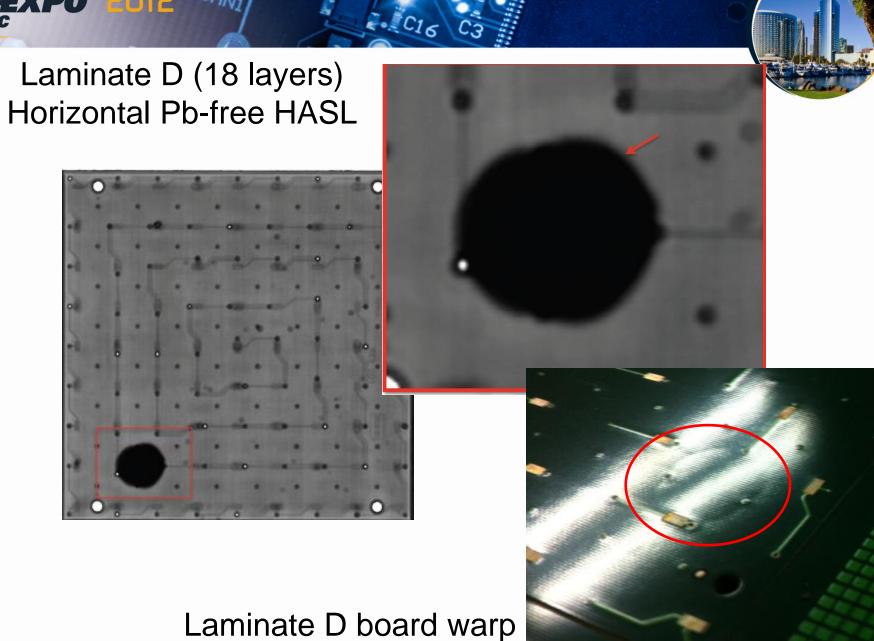
















Discussion of results:

- 1. All control boards with SnPb HASL had no voiding.
 - Immersion silver boards showed voiding. No plausible explanation.
- 2. The **immersion silver** boards showed the **same level of voiding as Pb-free HASL.** This shows that the Pb-free HASL itself was not the primary factor in voiding.
- 3. Vertical and horizontal HASL did not show any difference in voiding. Thermal impact between these 2 plating processes on the boards is comparable.
- 4. Laminate D at 18L cannot survive the necessary process steps, showing delamination and warp.
 - This further confirms why dicy cured materials should not be used for products which are undergoing Pb-free soldering and more so with Pb-free HASL surface finish.





Discussion (cont.):

- 5. Defect rate increases with higher layer count.
 - Cross-sections to determine failure location is not yet complete.
- 6. Voids are assumed to be precursors to delamination.
 - Degradation of the material is often internal and not visible to external visual inspection, necessitating SAM and cross-sections.
- 7. Pads on the immersion silver plated PCBs were missing after wave.
 - The extreme soak time of 7 seconds at wave soldering reflects the worst case scenario of a Pb-free wave soldering profile. Immersion silver boards immersed in the wave solder pot for this duration had pads missing.





Conclusions:

An important consideration for Pb-free materials, before any of the long-term reliability considerations are addressed, is the survivability of the laminates without degradation after the Pb-free assembly process. This survivability is further stressed if Pb-free HASL is used which adds another thermal cycle to the board during the fabrication process. As a chosen Pb-free compatible material approaches the 6 reflow and 1 wave thermal cycle limit, it is evident that we are very close to discovering more potential problems, with the early onset of voids.

This project concluded that

- Based on the HASL profiles, any laminate that is currently coated with tin lead HASL should be able to withstand the Pb-free HASL processing temperatures under the same dip time conditions.
- Material survivability performance of a Pb-free product depends on the type of material that is used and layer count of the board.
- There is no difference between immersion silver, vertical or horizontal Pb-free HASL on the reliability of the material.





Next Steps:

Cross-sections...

- > to characterize the voids
- > to understand the root cause of the voids





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- Schweizer for horizontal Pb-free HASL plating;
- Multek, Fastprint, Dysteq for test vehicle fabrication;
- QAV for conducting SAM Thru scans;
- Celestica JB for processing the test vehicles through the extreme Pb-free manufacturing environment;





References

- [1] "Considerations For Selecting A Printed Circuit Board Surface Finish", by R. Schueller, SMTA Int'l Proceedings, 2010.
- [2] "The hidden art of manufacturing multi-layered PCBs" by Stephen Sher, Cirtech Electronics.
- [3] "An Evaluation of Pb-free Surface Finishes' by Khaw Mei Ming, Agilent Technologies, SMTA Penang Proceedings, 2010.
- [4] "Hot air solder leveling in the Pb-free era" by Keith Sweatman, Nihon Superior, featured in EM Asia, Sept-Oct 09.





Thank you for your attention!

Any questions?





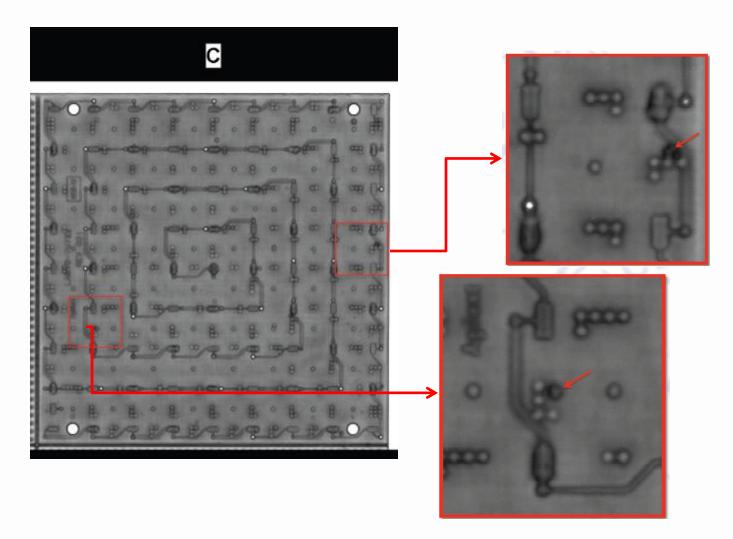


Back-up slides

More examples of voids

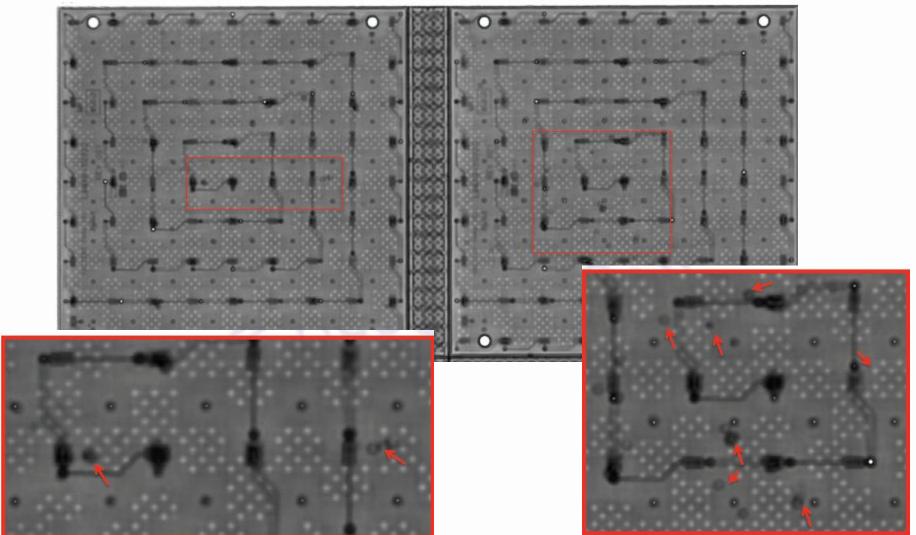


Laminate A (10 layers) Horizontal Pb-Free HASL





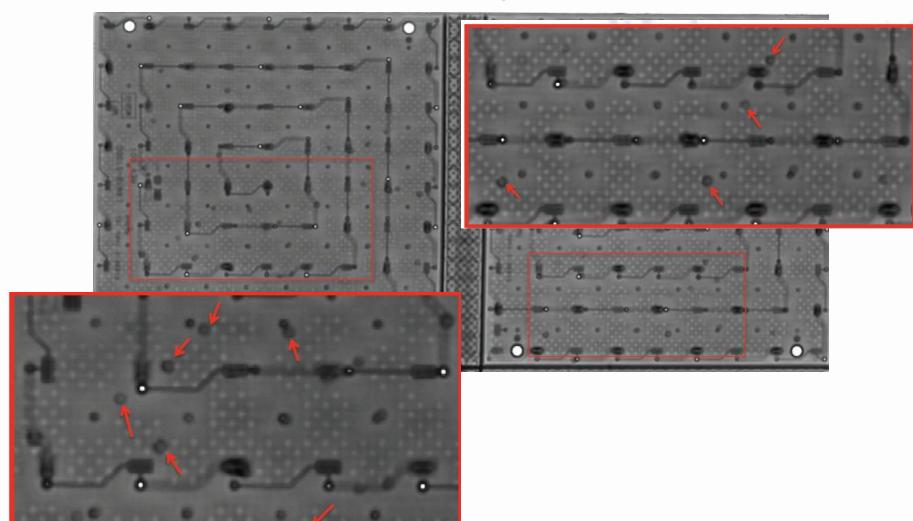
Laminate A (18 layers) Immersion Silver

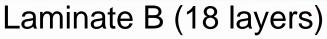




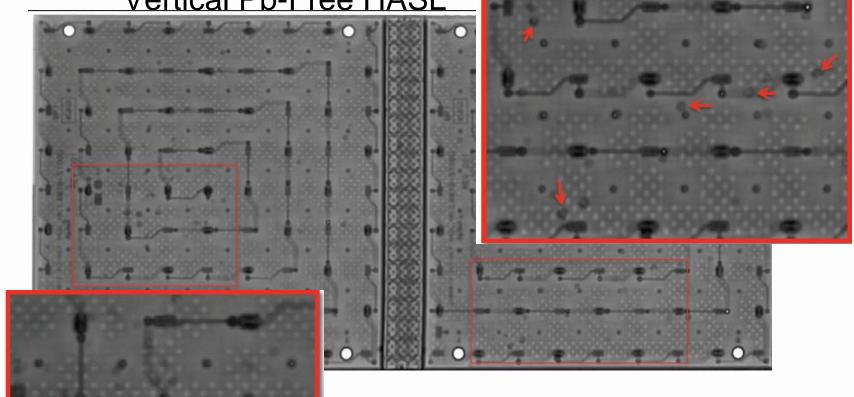


Laminate B (18 layers) Immersion Silver





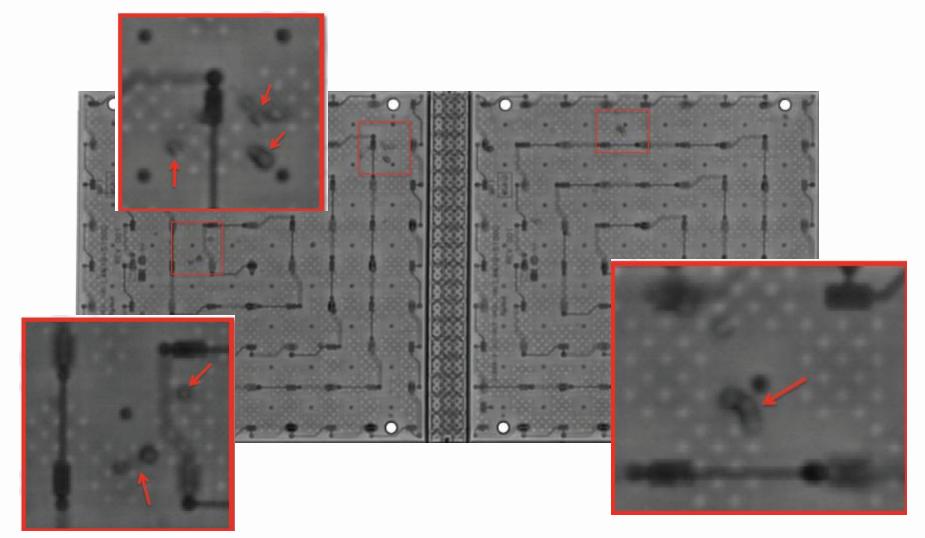




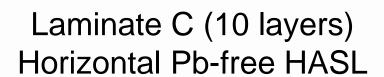


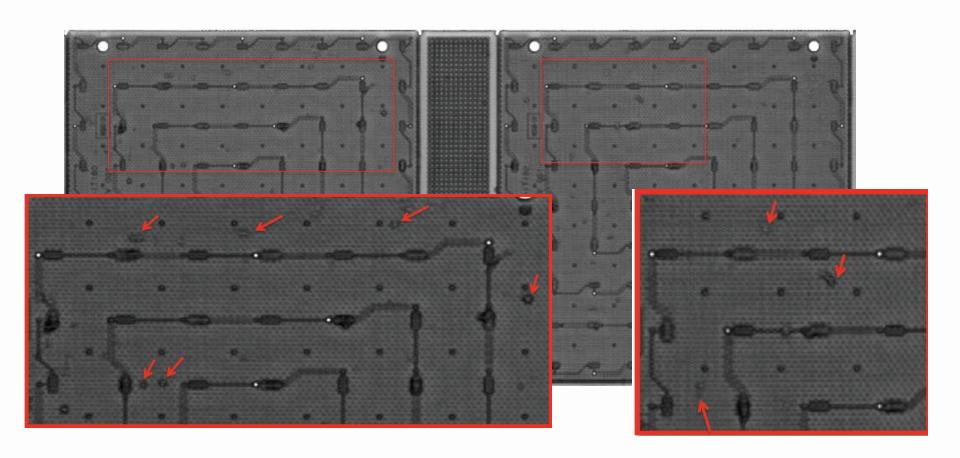


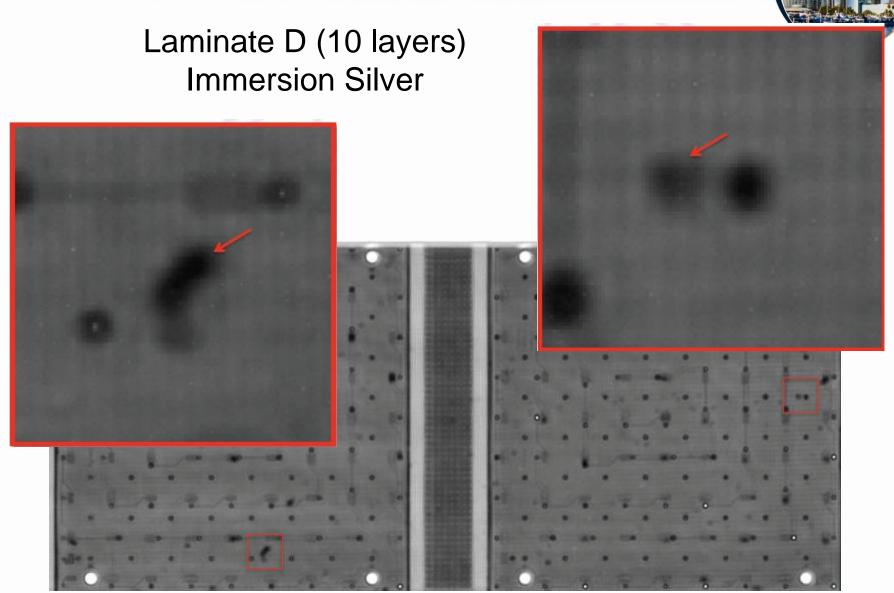
Laminate B (18 layers) Horizontal Pb-free HASL







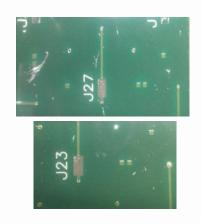


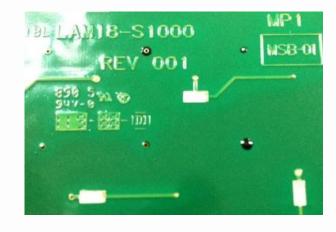












Missing pads after wave

Black ink after first reflow (only for horizontal HASL boards from a particular supplier)